

IECEx Certificate of Conformity

INTERNATIONAL ELECTROTECHNICAL COMMISSION

IEC Certification System for Explosive Atmospheres

for rules and details of the IECEx Scheme visit www.iecex.com

Certificate No.:	IECEX KEM 08.0020	Page 1 of 4	Certificate history:
Status:	Current	Issue No: 9	Issue 8 (2022-05-04) Issue 7 (2021-05-26) Issue 6 (2017-11-23)
Date of Issue:	2024-03-07		Issue 5 (2016-06-10)
Applicant:	Knick Elektronische Messgeräte Gmb Beuckestraße 22 14163 Berlin Germany	H & Co. KG	Issue 4 (2010-10-18) Issue 3 (2010-03-05) Issue 2 (2009-11-07) Issue 1 (2008-09-19) Issue 0 (2008-07-15)
Equipment:	Analyzing Units Stratos® Pro Types A T6, A211X…, A201B…, A221X… and A2 Multi Type E401X		
Optional accessory:			
Type of Protection:	Ex i and Ex e		
Marking:	Stratos® Pro Type A201X Type A211X Ex ia IIC T4 Ga or Ex ib [ia Ga] IIC T4 Gb or Ex ib [ia Da] IIIC T85 °C Db Stratos® Pro Type A201X-*-0-T6: Ex ia IIC T6 Ga Ex ib [ia Ga] IIC T6 Gb Ex ib [ia Ga] IIC T6 0° C Db Stratos® Pro Type A201B: Ex ic IIC T4 Gc or Ex ic IIIC T85 °C Dc Stratos® Pro Type A221X and A231X Ex ia IIC T6T4 Ga or Ex ib [ia Ga] IIC T6T4 Gb or Ex ic [ia Ga] IIC T6T4 Gc or Ex ib [ia Da] IIIC T80 °C Db Stratos® Multi Type E401X: Ex ec [ia Ga] IIC T4 Gc		
Approved for issue of Certification Body:	behalf of the IECEx	R. Schuller	
Position:		Certification Manager	
Signature: (for printed version)		Bluth	
Date: (for printed version)		2024-03-07	
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Manufacturer:	Knick Elektronische Messgeräte GmbH & Co. KG				
	Beuckestraße 22 14163 Berlin				
	Germany				
Manufacturing	Knick Elektronische Messgeräte GmbH & Co. KG				
locations.	Beuckestraße 22				
	14163 Berlin Germany				
This certificate is issued as verification that a sample(s), representative of production, was assessed and tested and found to comply with the IEC Standard list below and that the manufacturer's quality system, relating to the Ex products covered by this certificate, was assessed and found to comply with the IECEx Quality system requirements. This certificate is granted subject to the conditions as set out in IECEx Scheme Rules, IECEx 02 and Operational Documents as amended					
STANDARDS : The equipment and a to comply with the fol	any acceptable variations to it specified in the schedule of this certif llowing standards	ficate and the identified documents, was found			
IEC 60079-0:2017 Edition:7.0	Explosive atmospheres - Part 0: Equipment - General requirements				
IEC 60079-11:2011 Edition:6.0	Explosive atmospheres - Part 11: Equipment protection by intrins	ic safety "i"			
IEC 60079-15:2017 Edition:5.0	Explosive atmospheres - Part 15: Equipment protection by type of	of protection "n"			
IEC 60079-7:2017 Edition:5.1	Explosive atmospheres - Part 7: Equipment protection by increas	ed safety "e"			

This Certificate **does not** indicate compliance with safety and performance requirements other than those expressly included in the Standards listed above.

TEST & ASSESSMENT REPORTS:

A sample(s) of the equipment listed has successfully met the examination and test requirements as recorded in:

Test Reports:

NL/DEK/ExTR20.0048/02

NL/KEM/ExTR08.0017/08

Quality Assessment Report:

DE/TUN/QAR06.0016/12



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EQUIPMENT:

Equipment and systems covered by this Certificate are as follows:

Analyzing Units Stratos® Pro Types A201X..., A201X-*-0-T6, A211X..., A201B..., A221X... and A231X... and Stratos® Multi Type E401X... are used to measure and process electrochemical quantities in liquids in explosive atmospheres.

They consist of a main unit and a measurement module MK-... in a single enclosure. The main unit includes an electronic circuit with the connection terminals, a slot for one measurement module, a backlit LCD and a keypad. Stratos® Multi Type E401X... additionally has a connection for an optional memory card Type ZU1080-S-X-....

After processing of the measurement signals from the connected detector (connected to the terminals on the respective module or via the Memosens interface or a current input) the measured values are available on the display, as an analog output value (4 - 20 mA current signal with or without HART) or on the bus communication.

The Stratos® Pro Analyzers are provided with one or two isolated control inputs. Types A201X..., A201X-*-0-T6, A211X... and A201B... are supplied via the output signal loop. Types A221X... and A231X... are supplied via a FISCO bus system.

Analyzing Unit Stratos® Multi Type E401X... is provided with various isolated and non-isolated inputs, relay contacts and outputs. Stratos® Multi Type E401X... is supplied via its supply terminals.

The Analyzing Units consist of the units and one measurement module as specified in Annex 1.

Electrical data

For connection details and electrical data, refer to the control drawings of the Unit and Module.

Installation instructions

The instruction manual and the control drawings provided with the Unit or the Module shall be followed in detail to assure proper and safe operation.

SPECIFIC CONDITIONS OF USE: NO



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DETAILS OF CERTIFICATE CHANGES (for issues 1 and above) Minor constructional changes.

Annex:

Annex 1 to CoC IECEx KEM 08.0020.pdf



The Analyzing Units Stratos[®] Pro Types A201X..., A211X..., A201B..., A221X... and A231X... and Stratos[®] Multi Type E4...-.- consist of the following units and one measurement module:

Unit	Туре	Type of protection	Ambient temperature range	Control drawing
Stratos Pro	A201X A211X	Ex ia IIC T4 Ga Ex ib [ia Ga] IIC T4 Gb	T4 and T85 °C: -20 °C to +65 °C	212.002-100
		Ex ib [ia Da] IIIC T85 °C Db		
Stratos Pro	A221X	Ex ia IIC T6T4 Ga	T6:	212.002-100
	A231X	Ex ib [ia Ga] IIC T6…T4 Gb	-20 °C to +50 °C	
		Ex ic [ia Ga] IIC T6T4 Gc	T4 and T80 °C:	
		Ex ib [ia Da] IIIC T80 °C Db	-20 °C to +65 °C	
		FISCO Field Device		
Stratos Pro T6	A201X-*-0-T6	Ex ia IIC T6 Ga	-20 °C to +50 °C	212.002-100
		Ex ib [ia Ga] IIC T6 Gb		
		Ex ib [ia Da] IIIC T60 °C Db		
Stratos Multi	E401X	Ex ec [ia Ga] IIC T4 Gc	-20 °C to +55 °C	212.502-100
Memory card	ZU1080-S-X	Ex ic IIC Gc	-20 °C to +55 °C	212.502-100
			or as defined for the	
			main unit	
Measurement	Туре	Type of protection	Ambient	Control drawing
module			temperature range	
PH	MK-PH 015X	Ex ia IIC Ga	-20 °C to +65 °C	212.002-110
		Ex ia IIIC Da	or as defined for the	
			main unit	
OXY	MK-OXY 045X	Ex ia IIC Ga	-20 °C to +65 °C	212.002-120
		Ex ia IIIC Da	or as defined for the	
			main unit	
COND	MK-COND 025X	Ex ia IIC Ga	-20 °C to +65 °C	212.002-130
		Ex ia IIIC Da	or as defined for the	
			main unit	
CONDI	MK-CONDI 035X	Ex ia IIC Ga	-20 °C to +65 °C	212.002-140
		Ex ia IIIC Da	or as defined for the	
			main unit	
MS	MK-MS 095X	Ex ia IIC Ga	-20 °C to +65 °C	212.002-150
		Ex ia IIIC Da	or as defined for the	
			main unit	
The maximum su maximum ambie		x °C is referred to the enclosure		a dust layer at the

Table 2: Stratos Family for sensors with EPL Gc or Dc

Unit	Туре	Type of protection	Ambient temperature range	Control drawing
Stratos Pro	A201B	Ex ic IIC T4 Gc Ex ic IIIC T85 °C Dc	-20 °C to +65 °C	212.002-100
Measurement module	Туре	Type of protection	Ambient temperature range	Control drawing
PH	MK-PH 015B	Ex ic IIC Gc Ex ic IIIC Dc	-20 °C to +65 °C or as defined for the main unit	212.002-110
OXY	MK-OXY 045B	Ex ic IIC Gc Ex ic IIIC Dc	-20 °C to +65 °C or as defined for the main unit	212.002-120
COND	MK-COND 025B	Ex ic IIC Gc Ex ic IIIC Dc	-20 °C to +65 °C or as defined for the main unit	212.002-130
CONDI	MK-CONDI 035B	Ex ic IIC Gc Ex ic IIIC Dc	-20 °C to +65 °C or as defined for the main unit	212.002-140
The maximum su maximum ambier		x °C is referred to the enclosure	of the main unit without a	a dust layer at the